

AN5733

TV Volume Control Circuit

■ Description

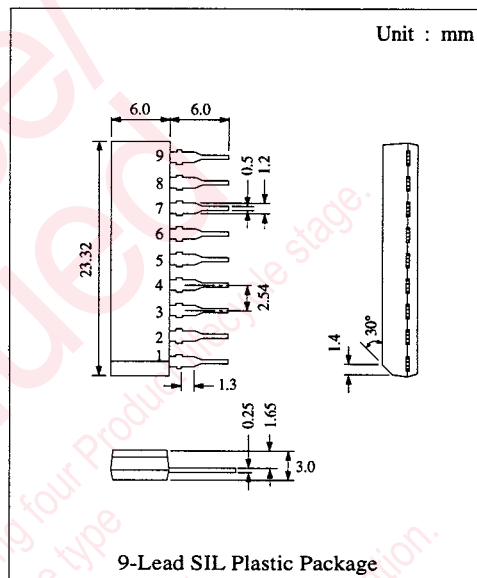
The AN5733 is an integrated circuit designed for TV volume control circuit.

■ Features

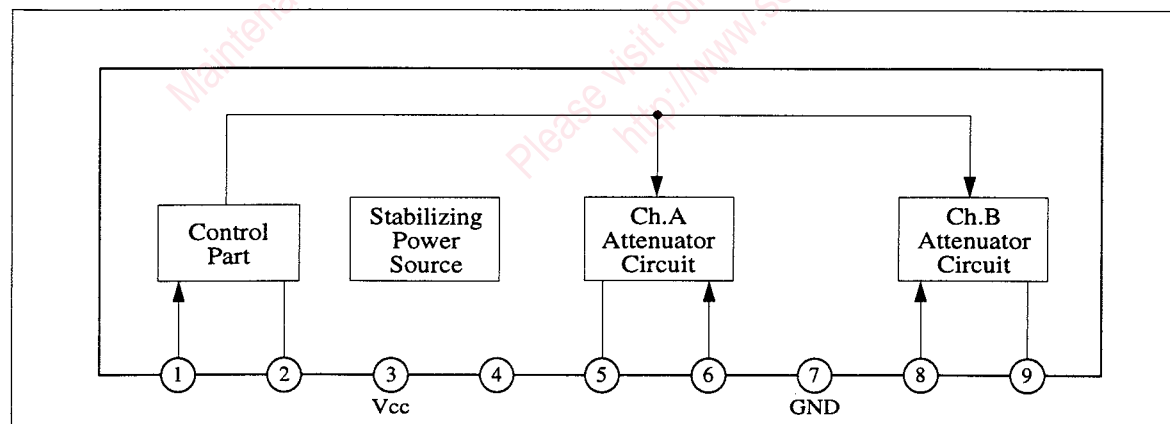
- Dual attenuator
- 9-lead SIL plastic package

■ Pin Descriptions

Pin No.	Pin Name
1	Control Voltage Input
2	Control Reference Voltage Output
3	Power Source (Vcc)
4	Decoupling
5	Ch.A Output Signal
6	Ch.A Input Signal
7	GND
8	Ch.B Input Signal
9	Ch.B Output Signal



■ Block Diagram



■ Absolute Maximum Ratings (Ta=25°C)

Item	Symbol	Rating	Unit
Supply Voltage	V _{CC}	14.4	V
Supply Current	I ₃	13.7	mA
Power Dissipation (Ta = 70°C)	P _D	197	mW
Operating Ambient Temperature	Topr	-40 ~ +150	°C
Storage Temperature	Tstg	-20 ~ +70	°C

■ Electrical Characteristics (Ta=25°C)

Item	Symbol	Test Circuit	Condition	min.	typ.	max.	Unit
Supply Voltage	I ₃		Table 1 (V _{CC} =12V)	9.5	11.3	13.5	mA
Terminal Voltage	V ₂₋₇		Table 1 (V _{CC} =12V)	3.8	4.1	4.45	V
Terminal Voltage	V ₄₋₇		Table 1 (V _{CC} =12V)	2.9	3.2	3.5	V
Terminal Voltage	V _{6-7, 8-7}		Table 1 (V _{CC} =12V)	2.0	2.4	2.8	V
Terminal Voltage	V _{5-7, 9-7}		Table 1 (V _{CC} =12V)	2.9	3.4	3.9	V
Circuit Gain (1) (VR=10kΩ)	G _{v⑤-1}	1	f=1kHz, V _L =500mVrms	4	6	7.6	dB
Circuit Gain (1) Ch. Relative Gain	ΔG ₋₁	1	f=1kHz, V _L =500mVrms	-1.5		1.5	dB
Circuit Gain (1) O/P Dist. Factor	THD	1	f=1kHz, V _L =500mVrms		0.2		%
Circuit Gain (2) (VR=5kΩ)	G _{v⑤-2}	1	f=1kHz, V _L =500mVrms	-2	0	2.2	dB
Circuit Gain (2) Ch. Relative Gain	ΔG ₋₂	1	f=1kHz, V _L =500mVrms	-2		2	dB
Circuit Gain (2) O/P Dist. Factor	THD	1	f=1kHz, V _L =500mVrms		0.2		%
Circuit Gain (3) (VR=1kΩ)	G _{v⑤-3}	1	f=1kHz, V _L =500mVrms	-20	-16	-12	dB
Circuit Gain (3) Ch. Relative Gain	ΔG ₋₃	1	f=1kHz, V _L =500mVrms	-2.5		2.5	dB
Maximum Attenuation (VR=0)	Att	1	f=1kHz, V _L =500mVrms	75			dB
Channel Separation	Sep	2	f=1kHz, V _L =500mVrms	70			dB
Input Impedance	R _{in}	3	f=1kHz		25		kΩ
Output Impedance	R _{out}	4	f=1kHz		1.7		kΩ
Hum Rejection	Hr		Table 1	34			dB
Noise Output Voltage	NO	1				180	μVrms
DC Output Voltage Fluctuation	ΔV _{5-7, 9-7}		Table 1 (V _{CC} =12V)	-0.2		0.3	V

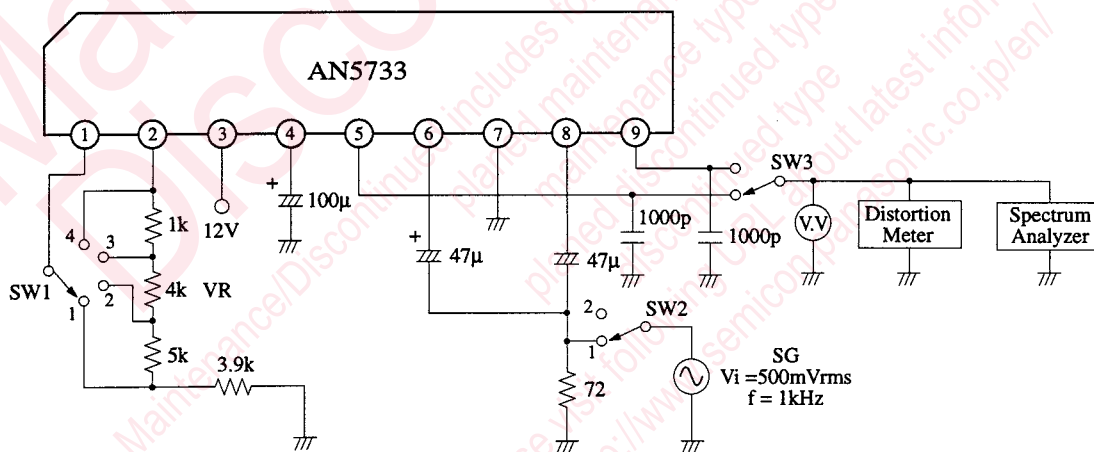
Table 1

Item	Symbol	Measuring Pin No.	Pin No.							Note				
			1	2	3	4	5	6	7		8	9		
Supply Voltage	I_3	3	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{2-7}	2	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{4-7}	4	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{6-7}	6	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{8-7}	8	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{5-7}	5	8.9k Ω 0V	5k Ω CON①	12V					0V				
Terminal Voltage	V_{9-7}	9	8.9k Ω 0V	5k Ω CON①	12V					0V				
Hum Rejection	Hr_5	5	8.9k Ω 0V	5k Ω CON①	14V					0V				1
Hum Rejection	ΔHr_5	5	8.9k Ω 0V	5k Ω CON①	10V					0V				1
Hum Rejection	Hr_g	9	8.9k Ω 0V	5k Ω CON①	14V					0V				2
Hum Rejection	ΔHr_g	9	8.9k Ω 0V	5k Ω CON①	10V					0V				2
DC Output Voltage	$V_{5-7, 9-7}$	5, 9	3.9k Ω 0V	10k Ω CON①	12V					0V				3,4
DC Output Voltage Fluctuation	$\Delta V_{5-7, 9-7}$	5, 9	CON②	13.9k Ω 0V	12V					0V				3,4

Obtain Hr of Pin No.5 by taking ratio of difference between changes of DC voltage of pin No. 5, i.e. Hr_5 and ΔHr_5 against change in supply voltage (4V). Similarly, obtain Hr of Pin No.9.

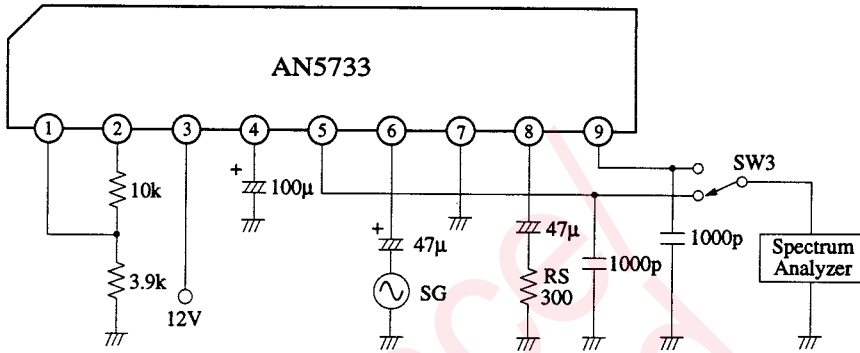
Note) 1. (18-2) - (18-1) : H_5 3. (20 upper) - (5 upper) : V_{5-7}
 2. (18-4) - (18-3) : H_9 4. (20 below) - (5 below) : V_{9-7}

Test Circuit 1



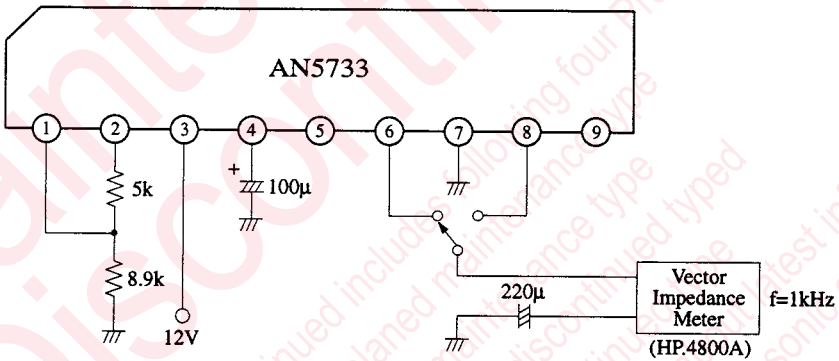
Item	Symbol	SW1	SW2
Circuit Gain (1) Ch. Relative Gain	ΔG_{-1}	1	1
Circuit Gain (1) O/P Dist. Factor	THD	1	1
Circuit Gain (2) (VR=5k Ω)	$G_{V②-2}$	1	1
Circuit Gain (2) Ch. Relative Gain	ΔG_{-2}	2	1
Circuit Gain (2) O/P Dist. Factor	THD	2	1
Circuit Gain (3) (VR=1k Ω)	$G_{V③-3}$	2	1
Circuit Gain (3) Ch. Relative Gain	ΔG_{-3}	3	1
Maximum Attenuation (VR=0)	Att	3	1
Channel Separation	Sep	4	1
Input Impedance	R_{in}	2	2

Test Circuit 2

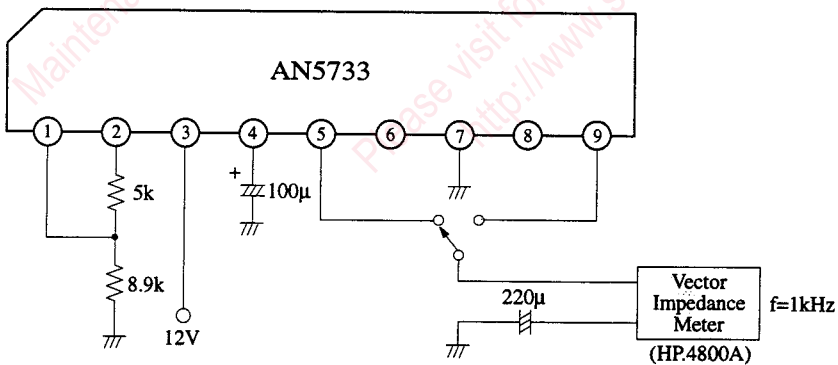


Note) Read level difference between Pin No.5 and Pin No.9 on the Spectrum Analyzer.
 Read level difference of Pin No.5 and Pin No.9, similarly after changing SG and RS.

Test Circuit 3



Test Circuit 4



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